
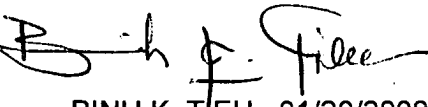


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/602,810	AN, KI CHUL	
	Examiner	Art Unit	
	/BINH K. TIEU/	2614	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
455		410			455	418			
INTERNATIONAL CLASSIFICATION					709	246			
H	0	4	M	3/16	726	22	24		
H	0	4	M	3/00					
				/					
				/					
				/					

(Assistant Examiner) (Date)		 BINH K. TIEU 01/20/2008	Total Claims Allowed: 6	
(Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 2

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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